OPTICAL PARAMETER MEASURING WITH TEMPERATURE ASSIGNMENT

BACKGROUND OF THE INVENTION

The present invention refers to measuring of optical parameters of optical devices.

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SUMMARY OF THE INVENTION

It is an object of the present invention to provide an improved measurement. The object is solved by the independent claim. Preferred embodiments are shown by the dependent claims.

- Providing a temperature signal and associating said temperature to the measured optical parameters allows a temperature depending evaluation of the optical parameters. An evaluation taking into consideration the temperature of the respective DUT improves the performance, the reproducibility and the reliability of the measurement.
- In the context of the present invention only optical parameters shall be referred to as "parameter", with temperature being explicitly excluded.

Since the measuring instrument is adapted to perform a real-time measurement of the parameters and the temperature, there can be created a very close relationship and in particular a definite association between the values of the parameters and the temperatures. This conjunction between parameters and associated temperature also allows an evaluation of the dependency of the parameters on the temperature.

Some characteristics of optical filters depend on temperature. For example a center wavelength of a specific type of filter, e.g. an arrayed waveguide, can be adjusted by varying temperature. With help of the invention it is possible to automatically determine the optimal operation temperature of the respective

filter and to automatically characterize the filter (by measuring its parameters) at its optimal operation temperature.

As mentioned above the optical characteristics of optical devices generally depend on temperature. Thus draught, e.g. caused by opening a door of a room in which the measurement takes place, may lead to a noticeable change of temperature and therefore to falsification of the measurement. With help of the invention the measurement results are comparable and reproducible.

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According to a preferred embodiment the measuring system comprises a heating and/or cooling device and/or at least one interface for connecting such a heating and/or cooling device to the measuring system. This heating and/or cooling device is provided for an active control of the temperature of the DUT to be measured. The measurement instrument is directly or via the interface connected to the heating and/or cooling device and is adapted for controlling it such that the heating and/or cooling device prior to the measurement adjusts a predetermined temperature at the DUT and during the measurement observes the predetermined temperature at the DUT. With help of such a heating and/or cooling device it is possible to perform the measurement within a predetermined range of admissible temperatures or nearly exactly at a predetermined optimum temperature. Keeping the temperature at a predetermined level improves the performance of the measurement.

BRIEF DESCRIPTION OF THE DRAWINGS

Other objects and many of the attendant advantages of the present invention will be readily appreciated and become better understood by reference to the following detailed description when considered in connection with the accompanying drawings. Features that are substantially or functionally equal or similar will be referred to with the same reference sign(s).

Fig. 1 is a schematic depiction of a measuring system according to the invention; and

Fig. 2 is a schematic illustration of a measurement protocol generated by the measuring system.

DETAILED DESCRIPTION OF PREFERRED EMBODIMENTS ACCRODING TO THE INVENTION

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Referring to Fig. 1, a measuring system 1 according to the invention comprises a component holder 2 adapted for providing a support of an optical device 3 to be measured. In the following said device 3 is referred to as "device under test" or "DUT"; consequently the component holder 2 is also referred to as DUT holder 2. Basically the DUT holder 2 can have any convenient form allowing a secure support of the DUT 3. In the depicted embodiment the DUT holder 2 is formed as a plate or table such that the DUT 3 can be applied onto the DUT holder 2. Preferably the DUT holder 2 is attached to a housing 4 of the measurement system 1 in such a way, that vibrations are damped. Therefore, the DUT holder 2 and the supported DUT 3 are isolated from vibrations appearing in the environment of the housing 4 and may be transferred to the housing 4.

The measuring system 1 also comprises at least one measuring instrument 5 with convenient hardware and software not shown. The measuring instrument 5 is adapted to perform measurement of optical parameters $P_1, P_2 \dots P_n$ (in the following abbreviated with P) of the DUT 3. To this aim the measurement instrument 5 has at least one optical output 6 and at least one optical input 7. In order to optically connect the DUT 3 to the measuring instrument 5 the output 6 of the measuring instrument 5 is connected to an optical input 8 of the DUT 3, and the input 7 of the measuring instrument 5 is connected to an optical output 9 of the DUT 3.

Such optical parameters P can be e.g. spectral loss, polarization depending loss, group delay, differential group delay in transmission and/or reflection. An

optical DUT 3 may be e.g. a simple optical fiber or an optical circuit or a highly integrated optical module.

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According to the invention the measuring system 1 comprises at least one temperature sensor 10 provided for measuring a temperature T of the DUT 3. Alternatively or additionally the measuring system 1 comprises at least one interface 11 for connecting such a temperature sensor 10. In Fig. 1 are exemplarily shown four of such temperature sensors 10, designated with 10', 10", 10" and 10"", respectively. The temperature sensors 10 are connected to the measuring instrument 5 via conductors 13 or 13', 13", 13"", respectively. These four or more or less temperature sensors 10 may be arranged alternatively or cumulatively.

One of the temperature sensors 10 designated with 10' is arranged at a carrier 12 supported by the housing 4. This temperature sensor 10' is adapted for a non-contact and therefore remote measurement of the temperature T of the DUT 3. Another temperature sensor 10 designated with 10" is attached to the DUT 3 provided for a direct measurement of the temperature T of the DUT 3. A further temperature sensor 10 designated with 10" is integrated into the DUT 3 adapted for measurement of an internal temperature T of the DUT 3. At last, another temperature sensor 10 designated with 10" is integrated into the DUT holder 2 and may stay in contact with the DUT 3 providing a direct measurement of the DUT's temperature T. Other convenient arrangements of temperature sensors 10 are not excluded.

The depicted and preferred embodiment of the measuring system 1 also comprises a heating and/or cooling device 14. Alternatively or additionally the measuring system 1 or the measuring instrument 5, respectively, comprises an interface 15 for connecting such a heating and/or cooling device 14 to the measuring system 1 or to the measuring instrument 5, respectively. The heating and/or cooling device 14 may have any suitable design and form.

Fig. 1 exemplarily depicts two alternative embodiments of such heating and/or cooling device 14, designated with 14' or 14", respectively. The one heating and/or cooling devices 14' has the form of a plate and is supported by the carrier 12. The other heating and/or cooling device 14" is integrated into the DUT holder 2. Such a heating and/or cooling device 14 is provided to increase or decrease the temperature T of the DUT 3. The measuring instrument 5 is directly or via the interface 15 connected to the respective heating and/or cooling device 14 by means of a controlling conductor 16 (or 16 or 16", respectively), and is adapted for an active control of the temperature T of the DUT 3. Therefore, prior to a measurement of parameters P the measuring instrument 5 triggers the respective heating and/or cooling device 14 for adjusting a predetermined temperature T at the DUT 3. During the measurement the measuring instrument 5 triggers the respective heating and/or cooling device 14 for observing the predetermined temperature T or for adjusting a predetermined development of the temperature T.

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The measuring system 1 as shown in Fig. 1 is also provided with a removable hood 17, which may be pivotable attached to the carrier 12, and which covers in this example the DUT holder 2, the DUT 3, the measuring instrument 5, the temperature sensor(s) 10, the carrier 12 and the heating and/or cooling device 14. This hood 17 protects the covered elements against environmental influences and thus improves the performance of the measurement. In a preferred embodiment the hood 17 is made of a thermal insulating material and/or has a thermal insulating design. This configuration provides a thermal isolation of the DUT 3 from the environmental conditions, and therefore leads to further improvement of the measurement.

The temperature sensor 10 or each of the temperature sensors 10, respectively, is adapted for providing a temperature signal correlating with the temperature T of the DUT 3, and sending it via the respective connector 13 to the measuring instrument 5. According to the invention the measuring instrument 5 is adapted to perform a simultaneous and real-time measurement

of the temperature T and the optical parameters P of the DUT 3. Preferably the measuring instrument 5 performs a temporally synchronized measurement simplifying an unambiguous or definite association between the optical parameters P and the temperature T of the DUT 3. In order to achieve a definite conjunction between temperature T and parameters P the measuring instrument 5 may be adapted for associating a measured temperature T to each measured parameter P or to each group of measured parameters P_1 , P_2 ... P_n .

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Now referring to Fig. 2 the measuring instrument 5 is preferably adapted to generate a measuring protocol 18, in particular in form of a matrix. In the protocol 18 or in the matrix, respectively, N is the number of each measuring interval or measuring step, in which the parameters P and the temperature T are determined. In this example the measuring number N counts from 1 to X intervals or steps. The protocol 18 lists also C, which is a timer signal or measuring time assigned to the measuring number N and hence assigned to the parameters P and the temperature T. The measuring number N and the timer signal C may be provided alternatively or additionally. The single parameters P_1 , P_2 ... P_n of each measuring number N are measured simultaneously, thus belong essentially to the same measuring time C and create a group of parameters P belonging together.

As can be seen in the matrix or protocol 18 of Fig. 2 the measuring instrument 5 determines a value of the temperature T for each measuring number N and/or at each measuring time C. This measurement routine or process leads to an unambiguous association of a definite temperature T to each single parameter P or to each group or parameters $P_1, P_2 \dots P_n$.

This protocol 18 allows a temperature depending evaluation of any single parameter P or of any group of parameters $P_1, P_2 \dots P_n$. With help of the protocol 18 it is also possible to evaluate the dependency of any single parameter P and/or of any group of parameters $P_1, P_2 \dots P_n$ on the

development of the temperature T. Therefore, on the one hand the performance of the parameter measurement can be improved with respect of its reliability and reproducibility. On the other hand an improved measurement leads to an improved control of quality of the optical DUTs 3.

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